Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10521313	LEE ET AL.
Examiner	Art Unit
KE/NN K HII I	1633

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST and PubMED: see updated search notes	4.17.08	KKH
STIC: SEQ ID NO:2, complete results available in SCORE		
EAST and PubMED: updated search, see attached search notes	1.07.09	KKH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

•

U.S. Patent and Trademark Office Part of Paper No.: